


<b>Search Notes</b> 	<b>Application/Control No.</b> 10534058	<b>Applicant(s)/Patent Under Reexamination</b> MASHITANI ET AL.
	<b>Examiner</b> HEE-YONG KIM	<b>Art Unit</b> 4192

SEARCHED			
Class	Subclass	Date	Examiner
382	154.232	6/24/2009	H.K
348	42-60	6/24/2009	H.K

SEARCH NOTES		
Search Notes	Date	Examiner
3D or stereo\$1scopic)( with (collision near detect\$4)	6/29/2009	H.K

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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